

Notice of References Cited

Application/Control No.

10/582,509

Applicant(s)/Patent Under
Reexamination
MIYASHITA ET AL.

Examiner

PATRICIA L. HAILEY

Art Unit

1793

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,180,835	04-1965	PERI JOHN B	516/33
*	B	US-5,160,452	11-1992	Marutsuka et al.	516/33
*	C	US-3,814,696	06-1974	Verdone et al.	516/33
*	D	US-4,309,454	01-1982	Feldstein, Nathan	427/98.1
*	E	US-3,841,881	10-1974	Feldstein et al.	106/1.11
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001-224969	08-2001	Japan	Nojima et al.	B01J 37/03
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.